

IR2113

HIGH AND LOW SIDE DRIVER

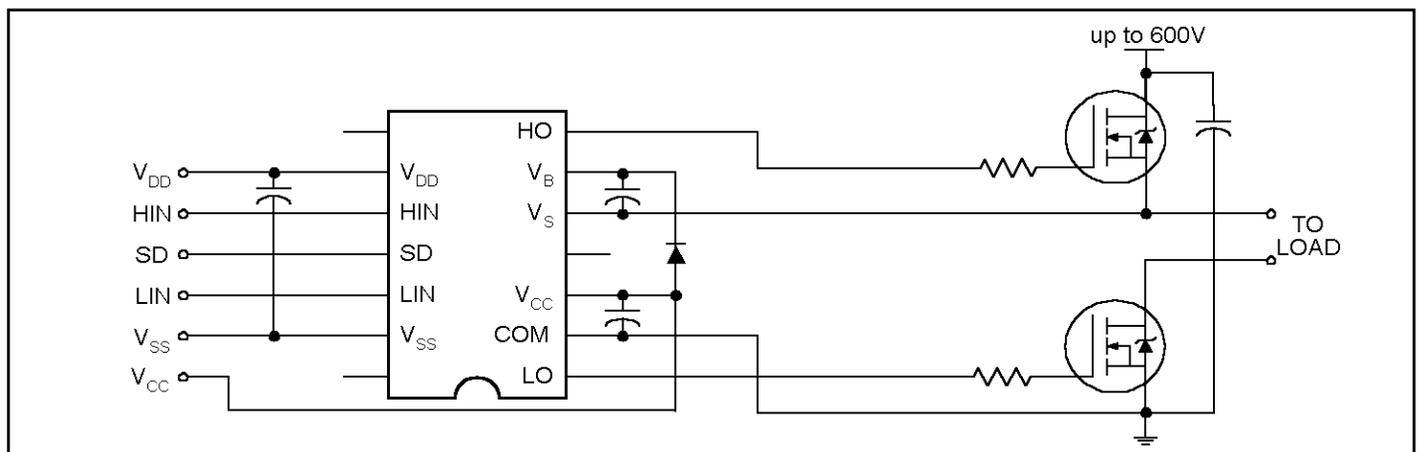
Features

- Floating channel designed for bootstrap operation
 - Fully operational to +600V
 - Tolerant to negative transient voltage
 - dV/dt immune
- Gate drive supply range from 10 to 20V
- Undervoltage lockout for both channels
- Separate logic supply range from 5 to 20V
 - Logic and power ground $\pm 5V$ offset
- CMOS Schmitt-triggered inputs with pull-down
- Cycle by cycle edge-triggered shutdown logic
- Matched propagation delay for both channels
- Outputs in phase with inputs

Description

The IR2113 is a high voltage, high speed power MOSFET and IGBT driver with independent high and low side referenced output channels. Proprietary HVIC and latch immune CMOS technologies enable ruggedized monolithic construction. Logic inputs are compatible with standard CMOS or LSTTL outputs. The output drivers feature a high pulse current buffer stage designed for minimum driver cross-conduction. Propagation delays are matched to simplify use in high frequency applications. The floating channel can be used to drive an N-channel power MOSFET or IGBT in the high side configuration which operates up to 600 volts.

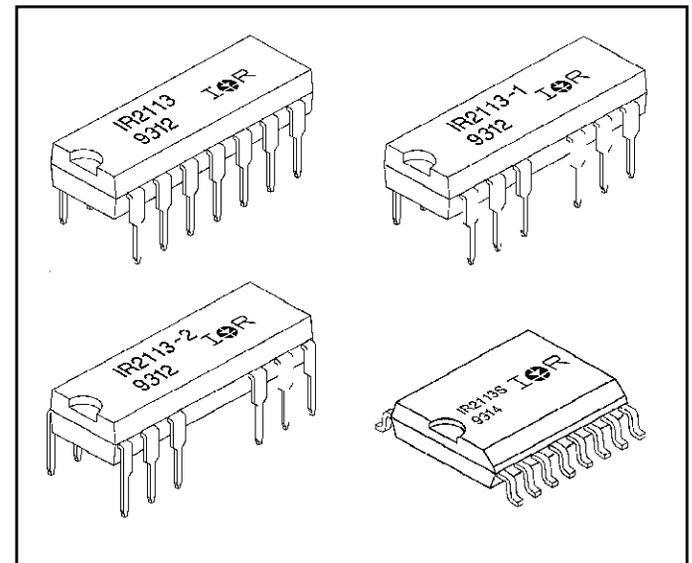
Typical Connection



Product Summary

| | |
|----------------------------------|------------------------|
| V_{OFFSET} | 600V max. |
| I_{O+/-} | 2A / 2A |
| V_{OUT} | 10 - 20V |
| t_{on/off} (typ.) | 120 & 94 ns |
| Delay Matching | 10 ns |

Packages



IR2113

Absolute Maximum Ratings



Absolute Maximum Ratings indicate sustained limits beyond which damage to the device may occur. All voltage parameters are absolute voltages referenced to COM. The Thermal Resistance and Power Dissipation ratings are measured under board mounted and still air conditions. Additional information is shown in Figures 28 through 35.

| Symbol | Parameter Definition | Value | | Units |
|---------------------|--|-----------------------|-----------------------|-------|
| | | Min. | Max. | |
| V _B | High Side Floating Supply Voltage | -0.3 | 625 | V |
| V _S | High Side Floating Supply Offset Voltage | V _B - 25 | V _B + 0.3 | |
| V _{HO} | High Side Floating Output Voltage | V _S - 0.3 | V _B + 0.3 | |
| V _{CC} | Low Side Fixed Supply Voltage | -0.3 | 25 | |
| V _{LO} | Low Side Output Voltage | -0.3 | V _{CC} + 0.3 | |
| V _{DD} | Logic Supply Voltage | -0.3 | V _{SS} + 25 | |
| V _{SS} | Logic Supply Offset Voltage | V _{CC} - 25 | V _{CC} + 0.3 | |
| V _{IN} | Logic Input Voltage (HIN, LIN & SD) | V _{SS} - 0.3 | V _{DD} + 0.3 | |
| dV _S /dt | Allowable Offset Supply Voltage Transient (Figure 2) | — | 50 | V/ns |
| P _D | Package Power Dissipation @ T _A ≤ +25°C (14 Lead DIP) | — | 1.6 | W |
| | (14 Lead DIP w/o Lead 4) | — | 1.5 | |
| | (16 Lead DIP w/o Leads 5 & 6) | — | 1.6 | |
| | (16 Lead SOIC) | — | 1.25 | |
| R _{θJA} | Thermal Resistance, Junction to Ambient (14 Lead DIP) | — | 75 | °CW |
| | (14 Lead DIP w/o Lead 4) | — | 85 | |
| | (16 Lead DIP w/o Leads 5 & 6) | — | 75 | |
| | (16 Lead SOIC) | — | 100 | |
| T _J | Junction Temperature | — | 150 | °C |
| T _S | Storage Temperature | -55 | 150 | |
| T _L | Lead Temperature (Soldering, 10 seconds) | — | 300 | |

Recommended Operating Conditions

The Input/Output logic timing diagram is shown in Figure 1. For proper operation the device should be used within the recommended conditions. The V_S and V_{SS} offset ratings are tested with all supplies biased at 15V differential. Typical ratings at other bias conditions are shown in Figures 36 and 37.

| Symbol | Parameter Definition | Value | | Units |
|-----------------|--|---------------------|----------------------|-------|
| | | Min. | Max. | |
| V _B | High Side Floating Supply Absolute Voltage | V _S + 10 | V _S + 20 | V |
| V _S | High Side Floating Supply Offset Voltage | Note 1 | 600 | |
| V _{HO} | High Side Floating Output Voltage | V _S | V _B | |
| V _{CC} | Low Side Fixed Supply Voltage | 10 | 20 | |
| V _{LO} | Low Side Output Voltage | 0 | V _{CC} | |
| V _{DD} | Logic Supply Voltage | V _{SS} + 5 | V _{SS} + 20 | |
| V _{SS} | Logic Supply Offset Voltage | -5 | 5 | |
| V _{IN} | Logic Input Voltage (HIN, LIN & SD) | V _{SS} | V _{DD} | |
| T _A | Ambient Temperature | -40 | 125 | °C |

Note 1: Logic operational for V_S of -5 to +600V. Logic state held for V_S of -5V to -V_{BS}.

Dynamic Electrical Characteristics

V_{BIAS} (V_{CC} , V_{BS} , V_{DD}) = 15V, C_L = 1000 pF, T_A = 25°C and V_{SS} = COM unless otherwise specified. The dynamic electrical characteristics are measured using the test circuit shown in Figure 3.

| Symbol | Parameter Definition | Figure | Value | | | Units | Test Conditions |
|-----------|-------------------------------------|--------|-------|------|------|-------|-----------------|
| | | | Min. | Typ. | Max. | | |
| t_{on} | Turn-On Propagation Delay | 7 | — | 120 | 150 | ns | $V_S = 0V$ |
| t_{off} | Turn-Off Propagation Delay | 8 | — | 94 | 125 | | $V_S = 600V$ |
| t_{sd} | Shutdown Propagation Delay | 9 | — | 110 | 140 | | $V_S = 600V$ |
| t_r | Turn-On Rise Time | 10 | — | 25 | 35 | | |
| t_f | Turn-Off Fall Time | 11 | — | 17 | 25 | | |
| MT | Delay Matching, HS & LS Turn-On/Off | — | — | — | 10 | | |

Static Electrical Characteristics

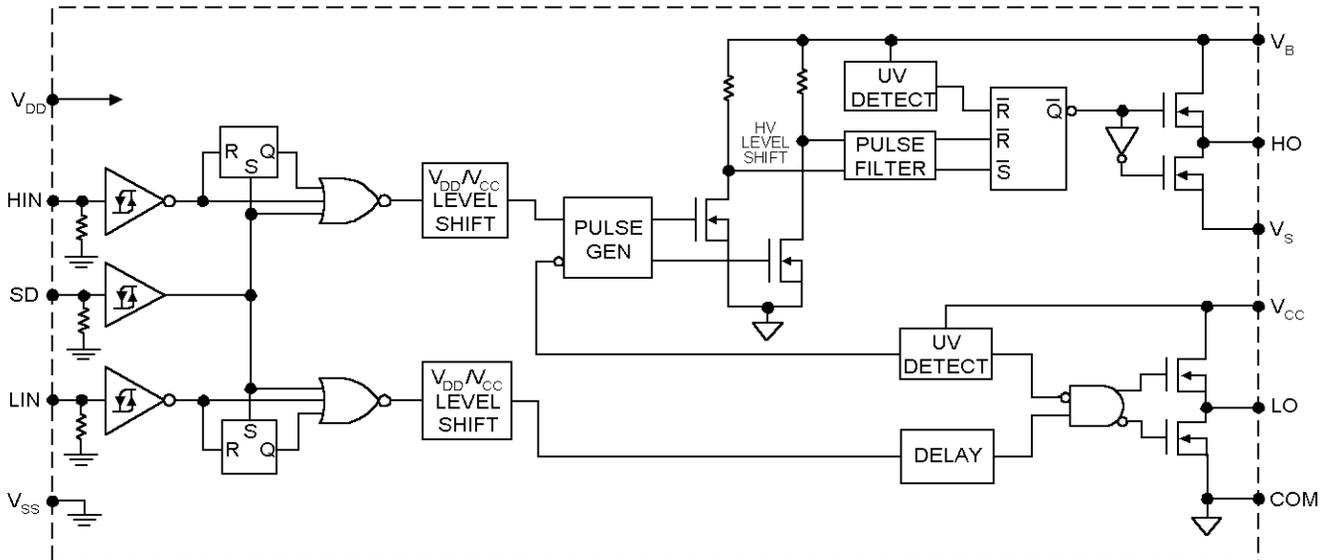
V_{BIAS} (V_{CC} , V_{BS} , V_{DD}) = 15V, T_A = 25°C and V_{SS} = COM unless otherwise specified. The V_{IH} , V_{TH} and I_{IN} parameters are referenced to V_{SS} and are applicable to all three logic input leads: HIN, LIN and SD. The V_O and I_O parameters are referenced to COM and are applicable to the respective output leads: HO or LO.

| Symbol | Parameter Definition | Figure | Value | | | Units | Test Conditions |
|-------------|---|--------|-------|------|------|---------|--|
| | | | Min. | Typ. | Max. | | |
| V_{IH} | Logic "1" Input Voltage | 12 | 9.5 | — | — | V | |
| V_{IL} | Logic "0" Input Voltage | 13 | — | — | 6.0 | | |
| V_{OH} | High Level Output Voltage, $V_{BIAS} - V_O$ | 14 | — | — | 1.2 | | $I_O = 0A$ |
| V_{OL} | Low Level Output Voltage, V_O | 15 | — | — | 0.1 | | $I_O = 0A$ |
| I_{LK} | Offset Supply Leakage Current | 16 | — | — | 50 | μA | $V_B = V_S = 600V$ |
| I_{QBS} | Quiescent V_{BS} Supply Current | 17 | — | 125 | 230 | | $V_{IN} = 0V$ or V_{DD} |
| I_{QCC} | Quiescent V_{CC} Supply Current | 18 | — | 180 | 340 | | $V_{IN} = 0V$ or V_{DD} |
| I_{QDD} | Quiescent V_{DD} Supply Current | 19 | — | 15 | 30 | | $V_{IN} = 0V$ or V_{DD} |
| I_{IN+} | Logic "1" Input Bias Current | 20 | — | 20 | 40 | | $V_{IN} = V_{DD}$ |
| I_{IN-} | Logic "0" Input Bias Current | 21 | — | — | 1.0 | | $V_{IN} = 0V$ |
| V_{BSUV+} | V_{BS} Supply Undervoltage Positive Going Threshold | 22 | 7.5 | 8.6 | 9.7 | V | |
| V_{BSUV-} | V_{BS} Supply Undervoltage Negative Going Threshold | 23 | 7.0 | 8.2 | 9.4 | | |
| V_{CCUV+} | V_{CC} Supply Undervoltage Positive Going Threshold | 24 | 7.4 | 8.5 | 9.6 | | |
| V_{CCUV-} | V_{CC} Supply Undervoltage Negative Going Threshold | 25 | 7.0 | 8.2 | 9.4 | | |
| I_{O+} | Output High Short Circuit Pulsed Current | 26 | 2.0 | 2.5 | — | A | $V_O = 0V$, $V_{IN} = V_{DD}$ $PW \leq 10 \mu s$ |
| I_{O-} | Output Low Short Circuit Pulsed Current | 27 | 2.0 | 2.5 | — | | $V_O = 15V$, $V_{IN} = 0V$ $PW \leq 10 \mu s$ |

IR2113



Functional Block Diagram



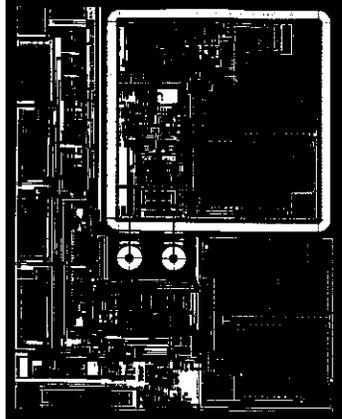
Lead Definitions

| Symbol | Description |
|-----------------|---|
| V _{DD} | Logic supply |
| HIN | Logic input for high side gate driver output (HO), in phase |
| SD | Logic input for shutdown |
| LIN | Logic input for low side gate driver output (LO), in phase |
| V _{SS} | Logic ground |
| V _B | High side floating supply |
| HO | High side gate drive output |
| V _S | High side floating supply return |
| V _{CC} | Low side supply |
| LO | Low side gate drive output |
| COM | Low side return |

Lead Assignments

| | | | |
|--------------------|-------------------------------|--|---------------------------------|
| <p>14 Lead DIP</p> | <p>14 Lead DIP w/o Lead 4</p> | <p>16 Lead DIP w/o Leads 4 & 5</p> | <p>16 Lead SOIC (Wide Body)</p> |
| IR2113 | IR2113-1 | IR2113-2 | IR2113S |
| Part Number | | | |

Device Information

| | | |
|-------------------------|--------------|---|
| Process & Design Rule | | HVDCMOS 4.0 μm |
| Transistor Count | | 220 |
| Die Size | | 98 X 126 X 26 (mil) |
| Die Outline | |  |
| Thickness of Gate Oxide | | 800Å |
| Connections | Material | Poly Silicon |
| | First Layer | |
| | Width | 4 μm |
| | Spacing | 6 μm |
| | Thickness | 5000Å |
| Second Layer | Material | Al - Si (Si: 1.0% \pm 0.1%) |
| | Width | 6 μm |
| | Spacing | 9 μm |
| | Thickness | 20,000Å |
| Contact Hole Dimension | | 8 μm X 8 μm |
| Insulation Layer | Material | PSG (SiO_2) |
| | Thickness | 1.5 μm |
| Passivation | Material | PSG (SiO_2) |
| | Thickness | 1.5 μm |
| Method of Saw | | Full Cut |
| Method of Die Bond | | Ablebond 84 - 1 |
| Wire Bond | Method | Thermo Sonic |
| | Material | Au (1.0 mil / 1.3 mil) |
| Leadframe | Material | Cu |
| | Die Area | Ag |
| | Lead Plating | Pb : Sn (37 : 63) |
| Package | Types | 14 & 16 Lead PDIP / 16 Lead SOIC |
| | Materials | EME6300 / MP150 / MP190 |
| Remarks: | | |

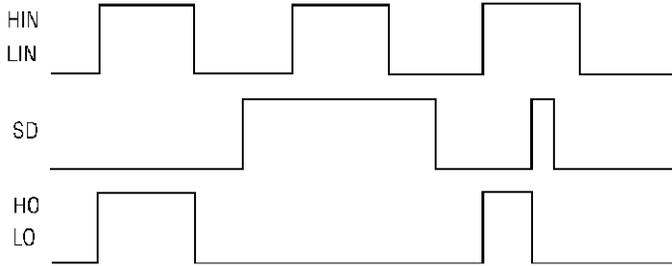


Figure 1. Input/Output Timing Diagram

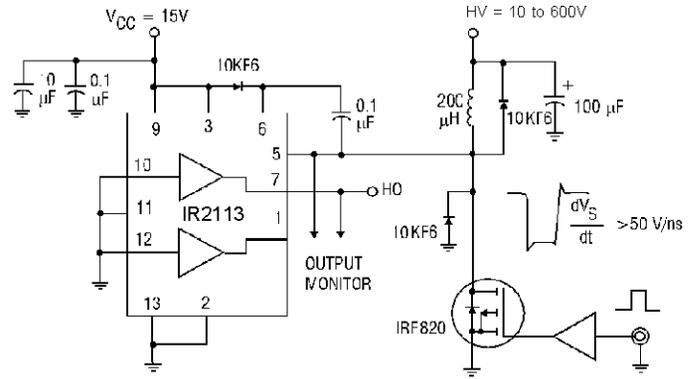


Figure 2. Floating Supply Voltage Transient Test Circuit

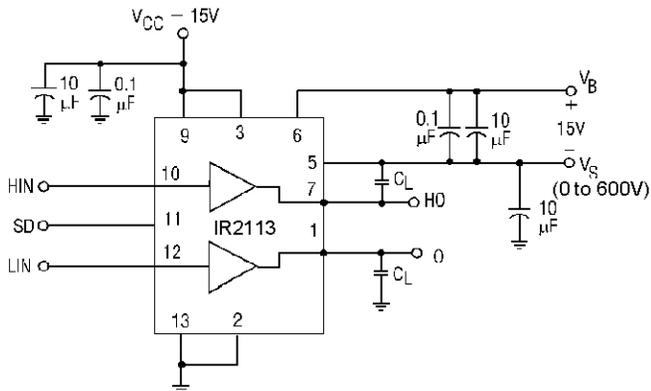


Figure 3. Switching Time Test Circuit

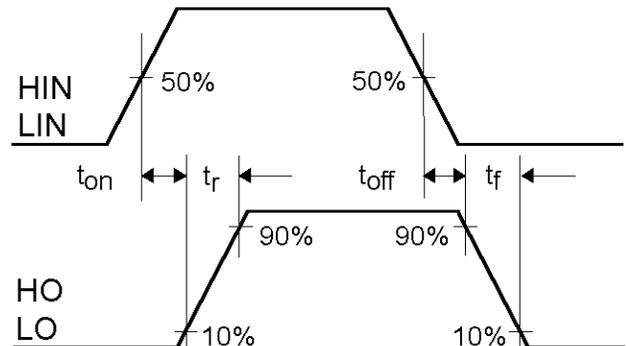


Figure 4. Switching Time Waveform Definition

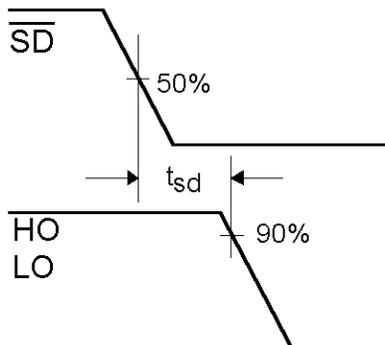


Figure 3. Shutdown Waveform Definitions

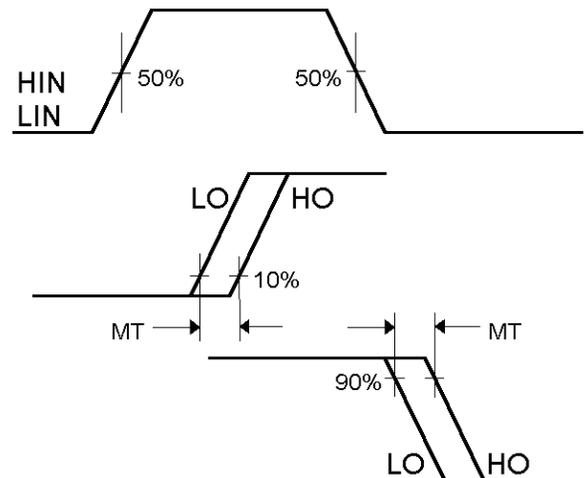
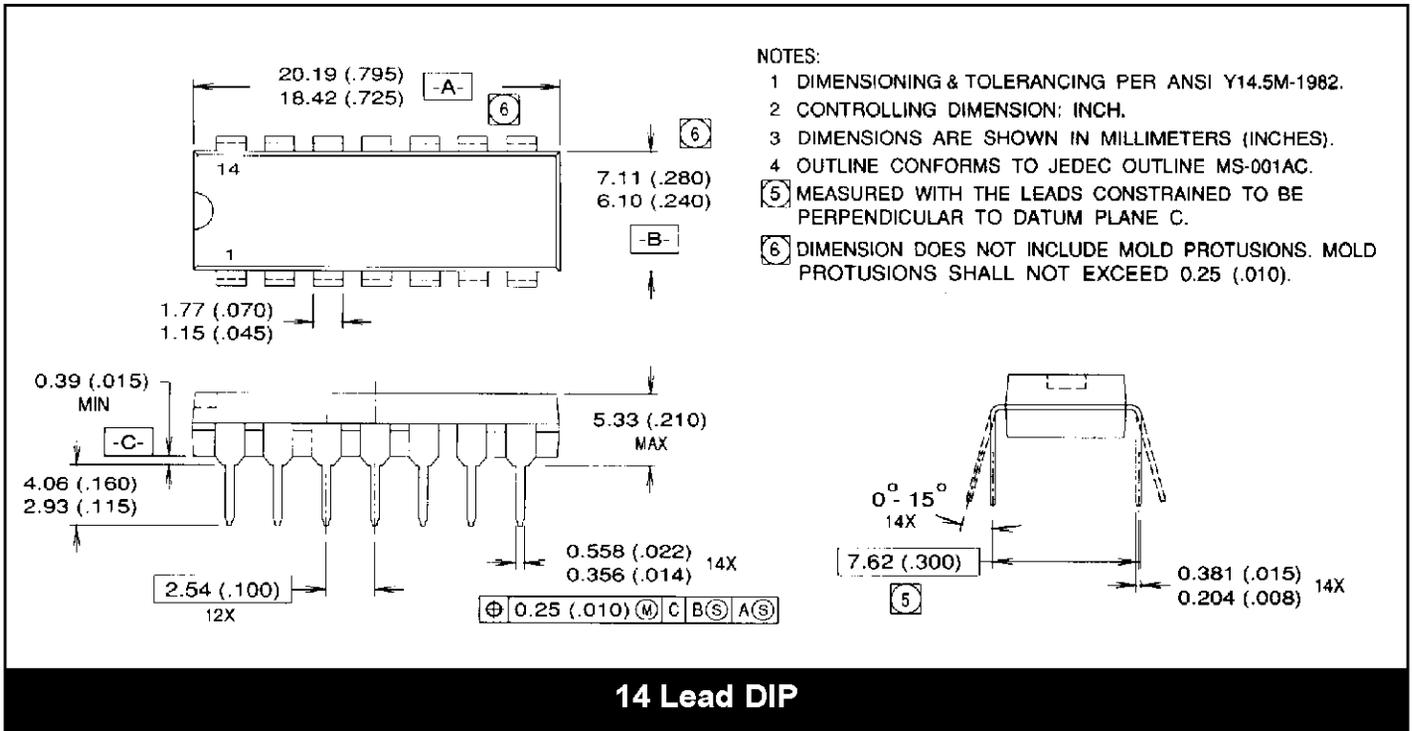
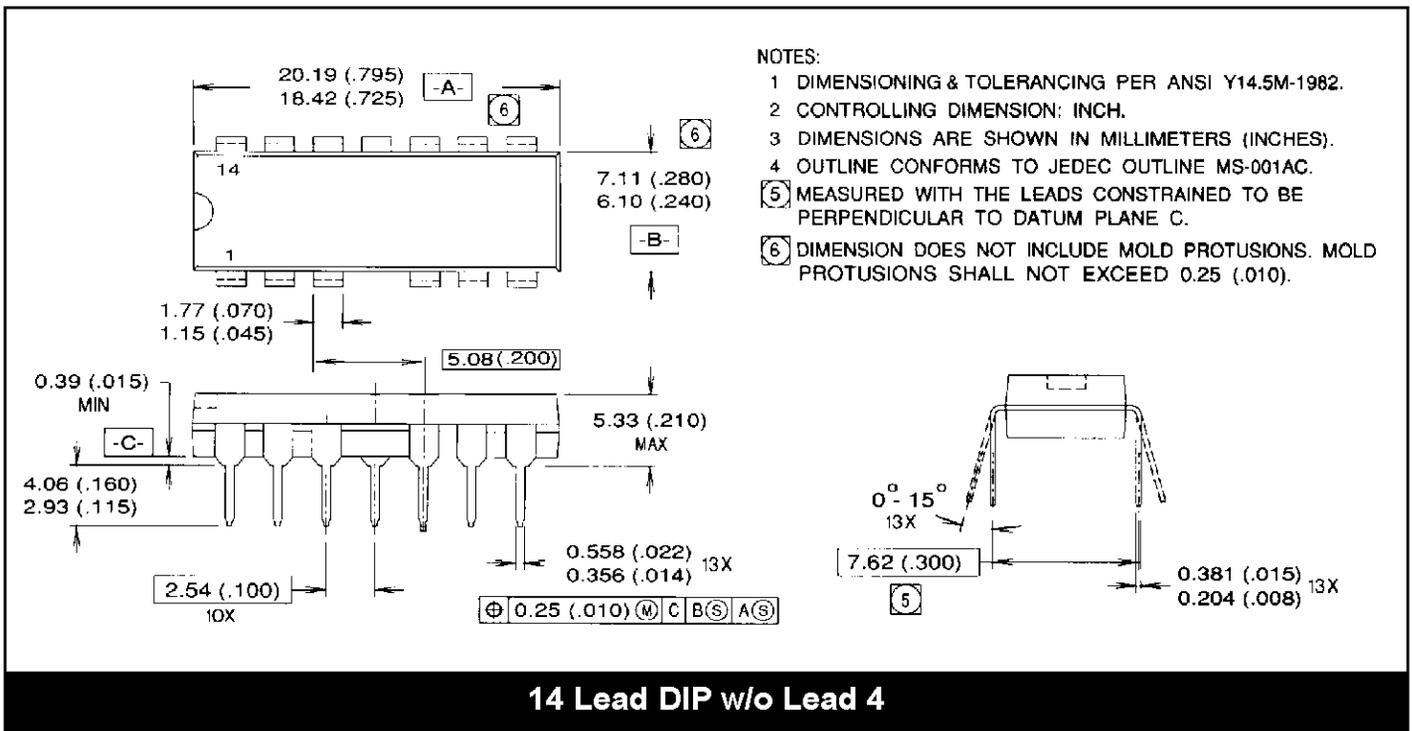


Figure 6. Delay Matching Waveform Definitions



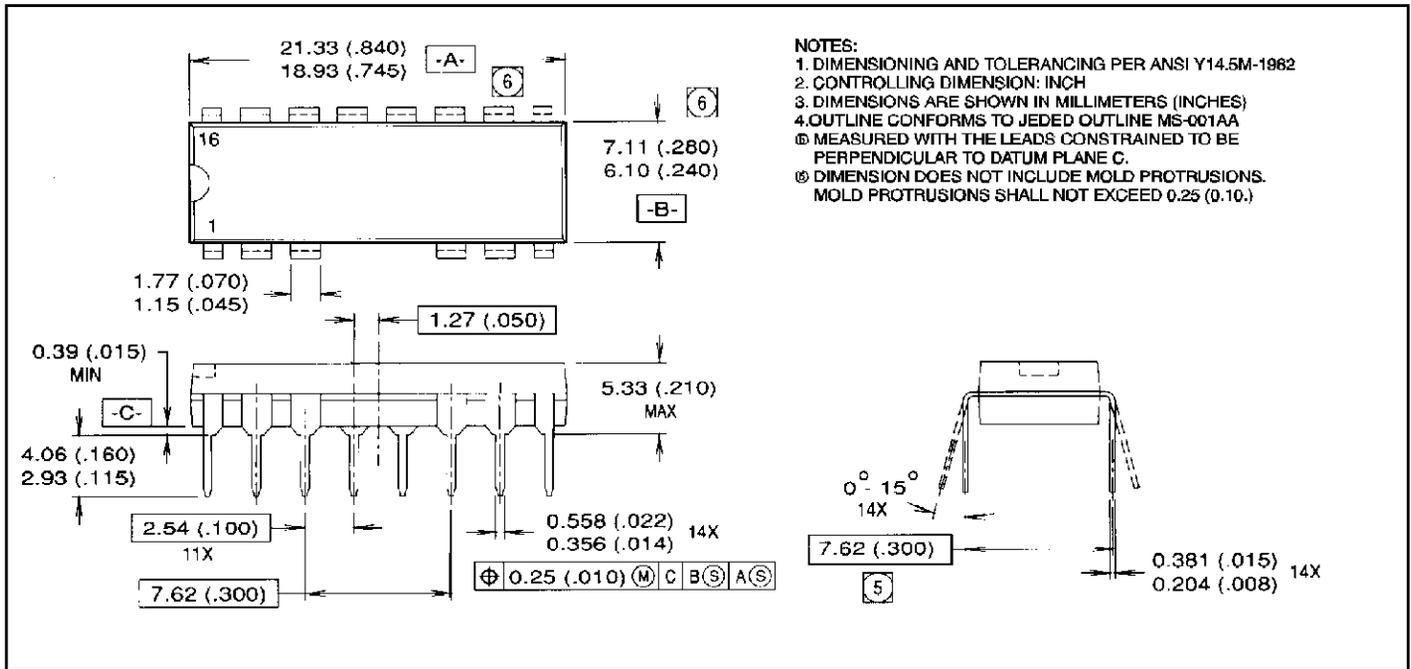
NOTES:

- 1 DIMENSIONING & TOLERANCING PER ANSI Y14.5M-1982.
- 2 CONTROLLING DIMENSION: INCH.
- 3 DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
- 4 OUTLINE CONFORMS TO JEDEC OUTLINE MS-001AC.
- 5 MEASURED WITH THE LEADS CONSTRAINED TO BE PERPENDICULAR TO DATUM PLANE C.
- 6 DIMENSION DOES NOT INCLUDE MOLD PROTUSIONS. MOLD PROTUSIONS SHALL NOT EXCEED 0.25 (.010).

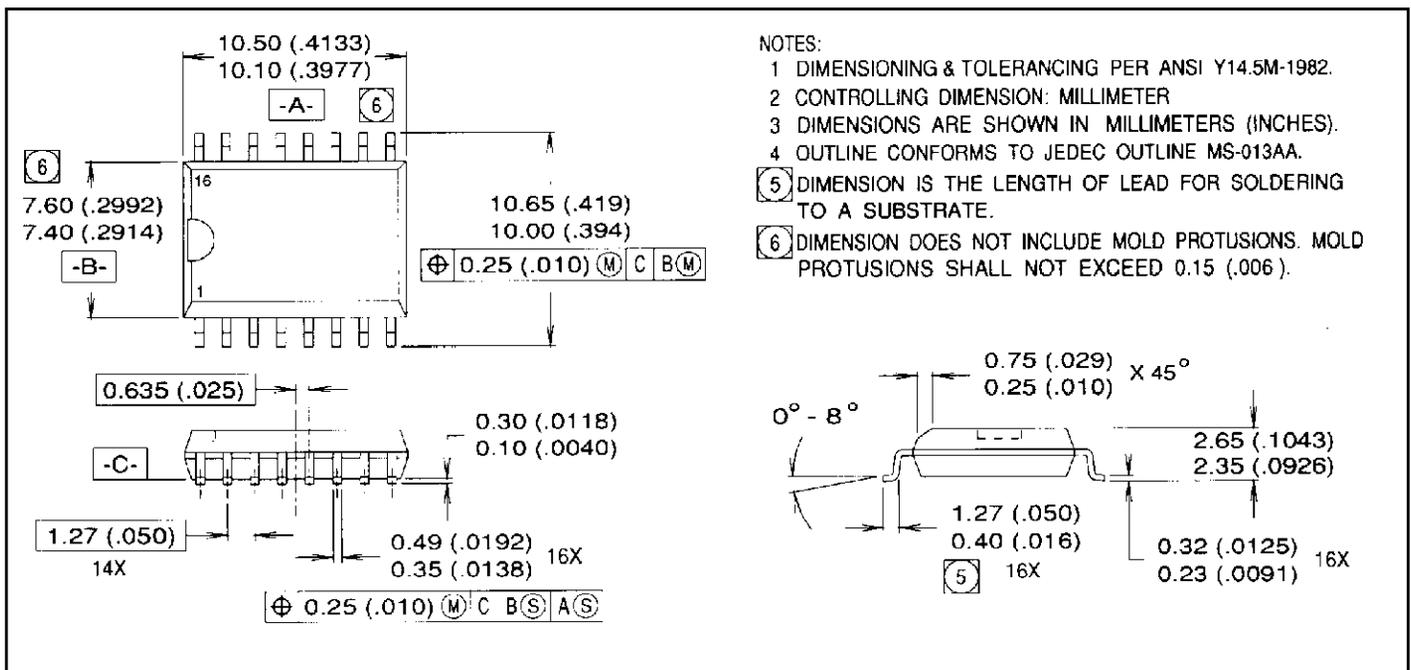


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16 Lead DIP w/o Leads 5 & 6



16 Lead SOIC, Wide Body



The **Graphs** listed below are also available on the
Fax-On-Demand system by selecting
Document Number - 70030

IR2113 Graphs - 9 Pages

Temperature and Voltage vs. the following Parameters:

Turn-On and Turn-Off Time
Shutdown Time
Turn-On Rise Time
Turn-Off Fall Time
Logic "1" and Logic "0" Input Threshold
High and Low Level Output
Offset Supply Current
 V_{BS} , V_{CC} , V_{DD} Supply Current
Logic "1" and Logic "0" Input Current
Output Source and Sink Current

Temperature vs. the following Parameters:

V_{BS} and V_{CC} Undervoltage (+)
 V_{BS} and V_{CC} Undervoltage (-)

IR2110 T_j vs. Frequency for the following Devices:

IRFBC20, IRFBC30, IRFBC40, IRFPE50

Maximum V_s Negative Offset vs. V_{BS} Supply Voltage
Maximum V_s Positive Offset vs. V_{CC} Supply Voltage

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Data and specifications subject to change without notice.

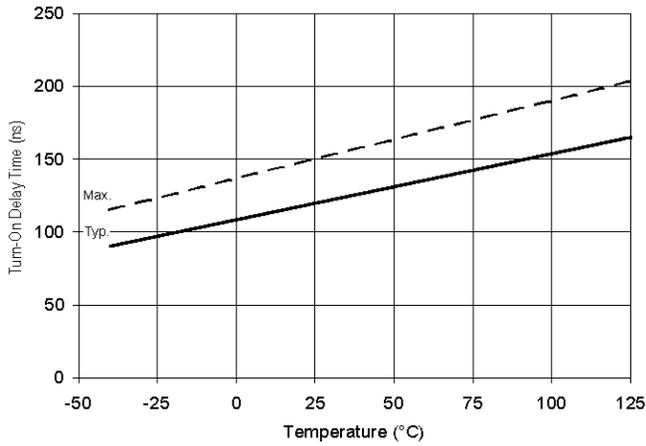


Figure 7A. Turn-On Time vs. Temperature

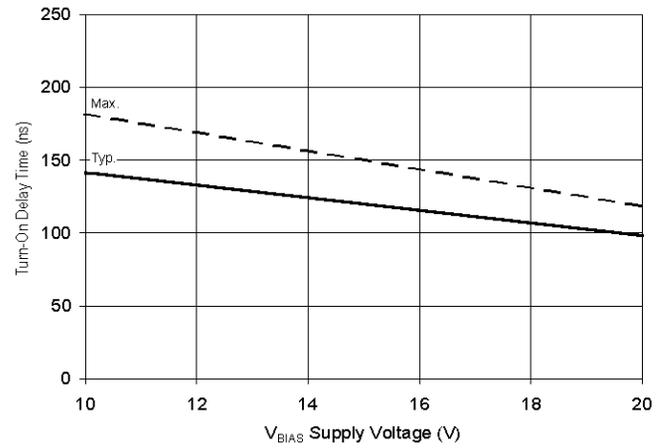


Figure 7B. Turn-On Time vs. Voltage

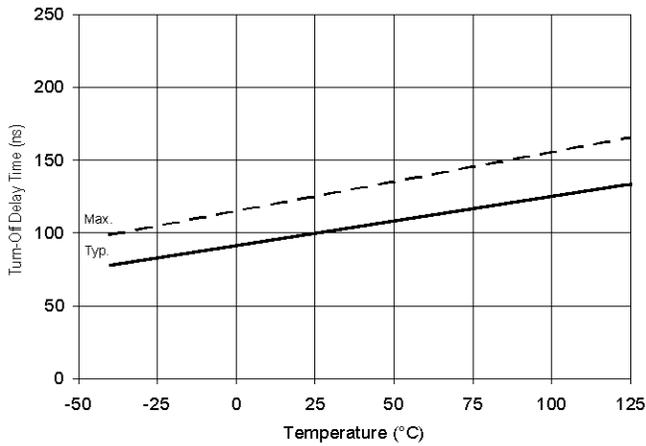


Figure 8A. Turn-Off Time vs. Temperature

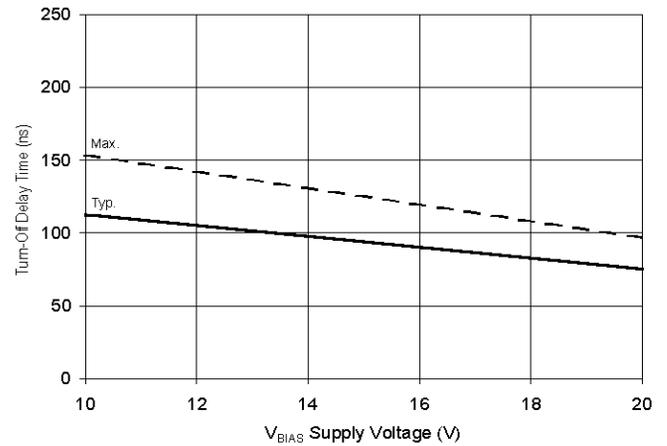


Figure 8B. Turn-Off Time vs. Voltage

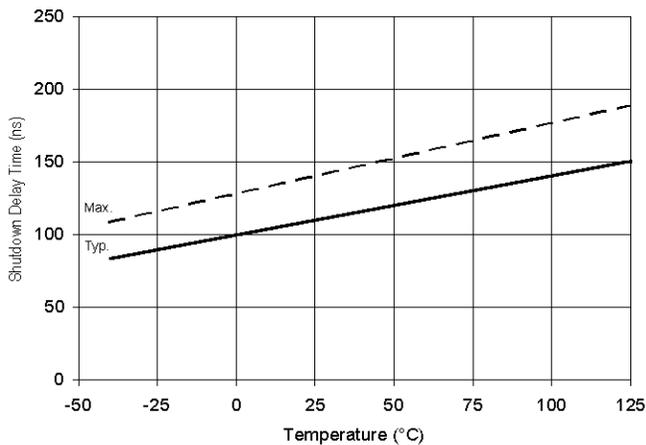


Figure 9A. Shutdown Time vs. Temperature

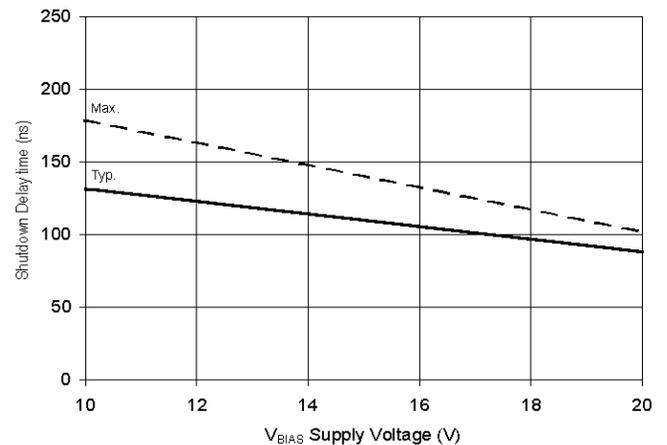


Figure 9B. Shutdown Time vs. Voltage

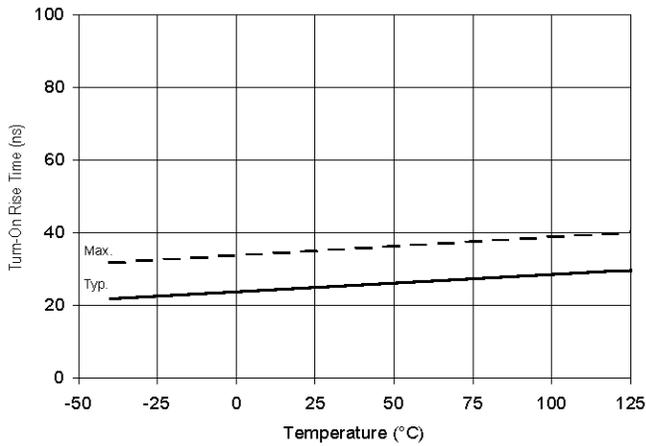


Figure 10A. Turn-On Rise Time vs. Temperature

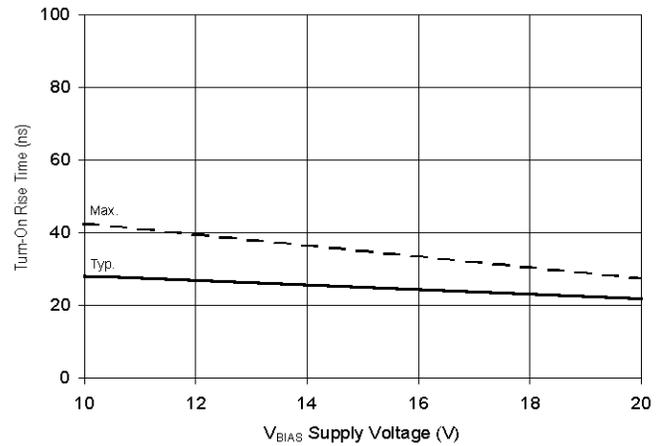


Figure 10B. Turn-On Rise Time vs. Voltage

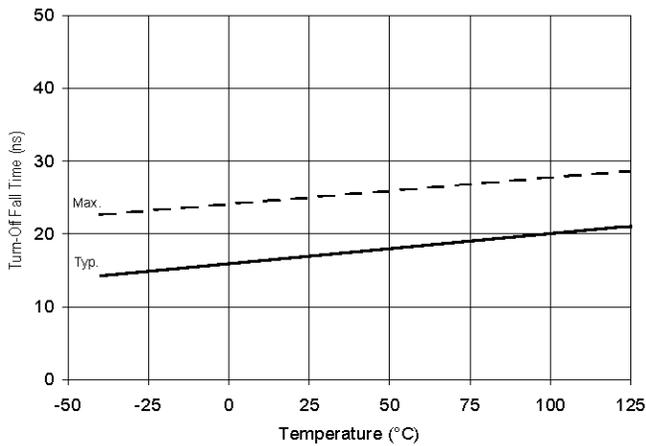


Figure 11A. Turn-Off Fall Time vs. Temperature

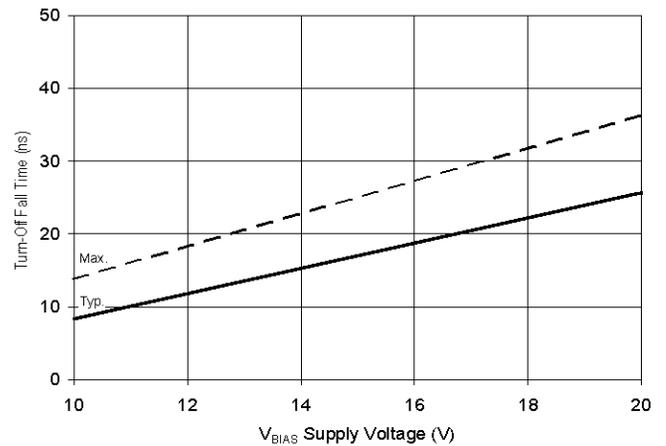


Figure 11B. Turn-Off Fall Time vs. Voltage

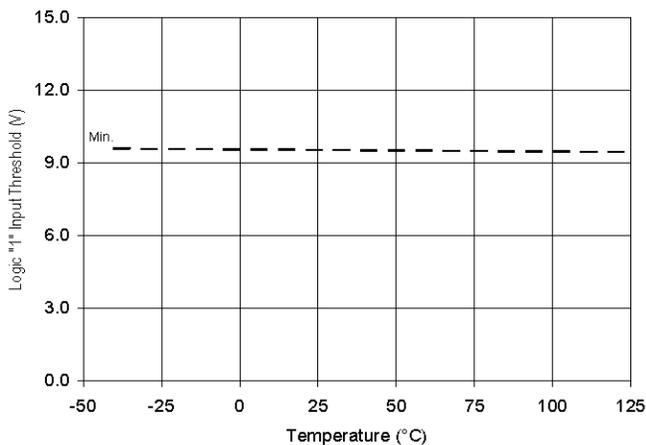


Figure 12A. Logic "1" Input Threshold vs. Temperature

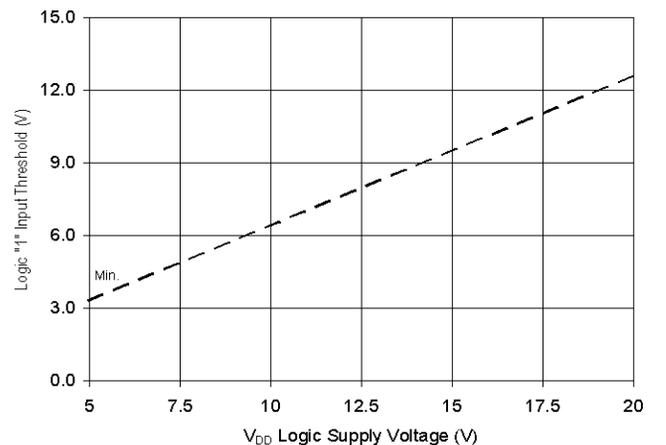


Figure 12B. Logic "1" Input Threshold vs. Voltage

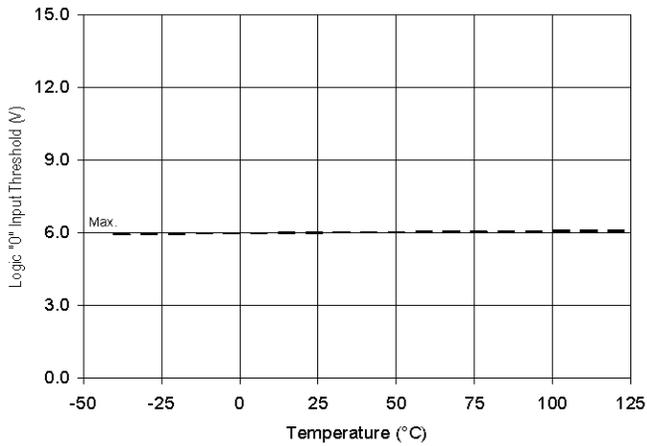


Figure 13A. Logic "0" Input Threshold vs. Temperature

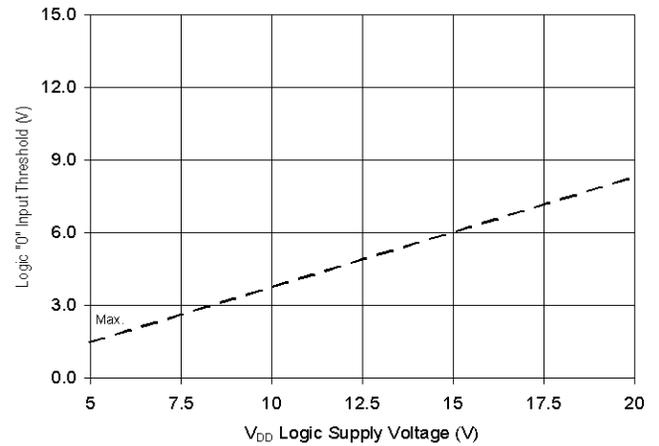


Figure 13B. Logic "0" Input Threshold vs. Voltage

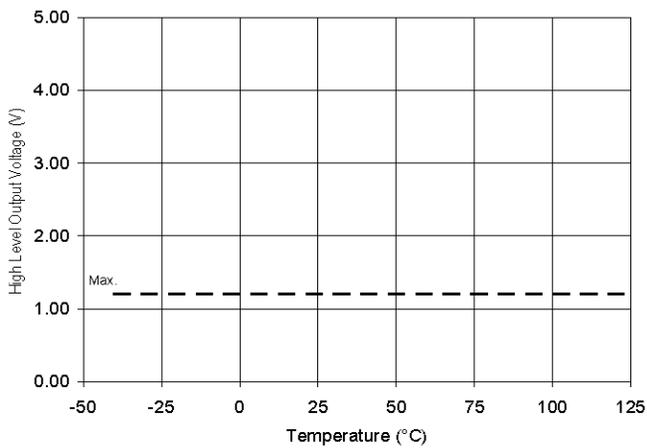


Figure 14A. High Level Output vs. Temperature

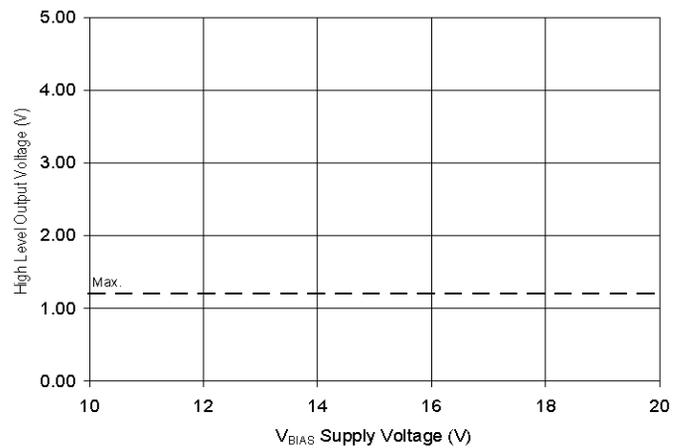


Figure 14B. High Level Output vs. Voltage

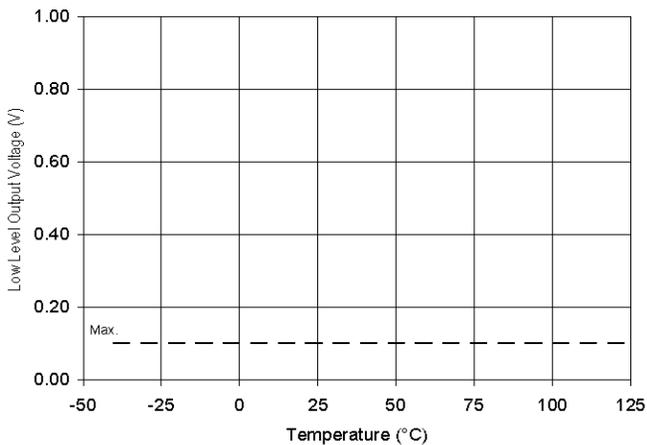


Figure 15A. Low Level Output vs. Temperature

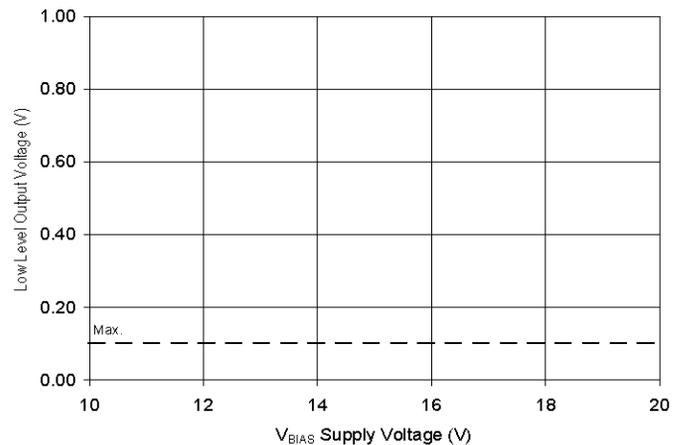


Figure 15B. Low Level Output vs. Voltage

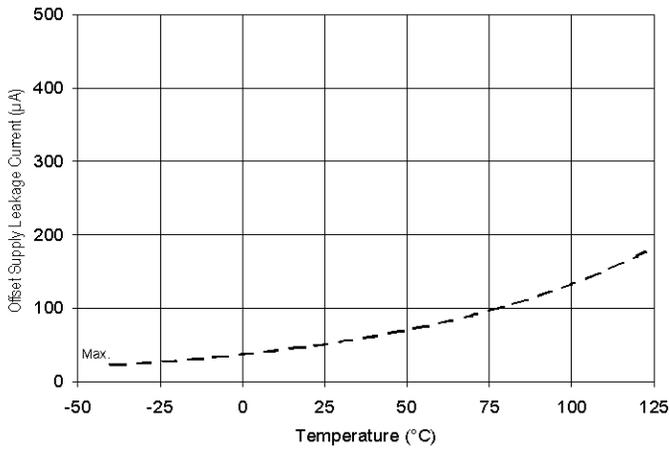


Figure 16A. Offset Supply Current vs. Temperature

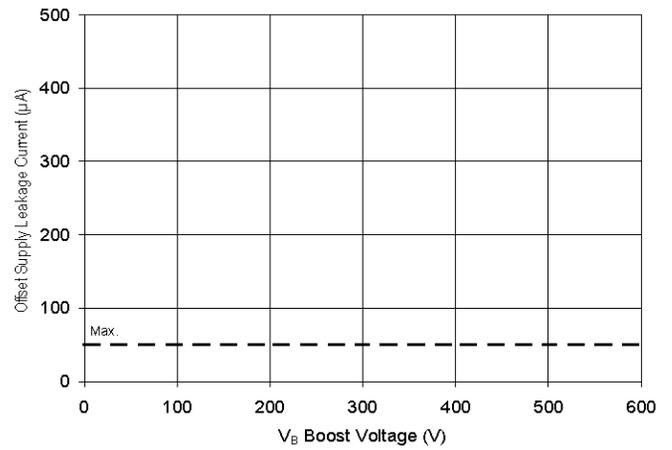


Figure 16B. Offset Supply Current vs. Voltage

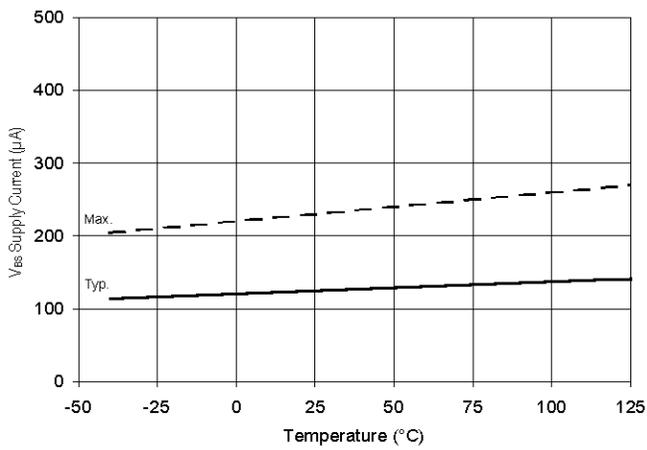


Figure 17A. V_{BS} Supply Current vs. Temperature

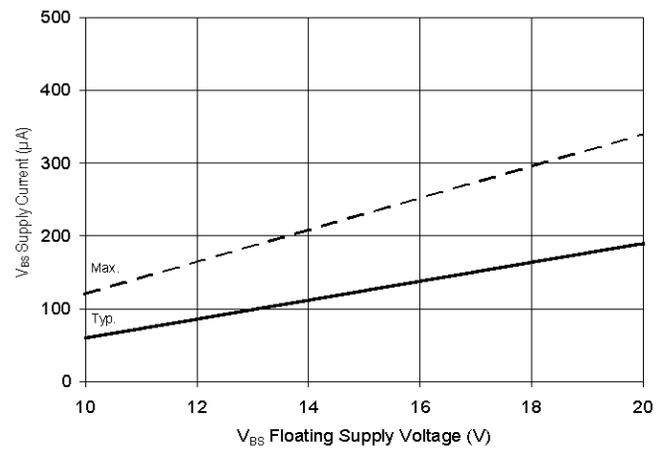


Figure 17B. V_{BS} Supply Current vs. Voltage

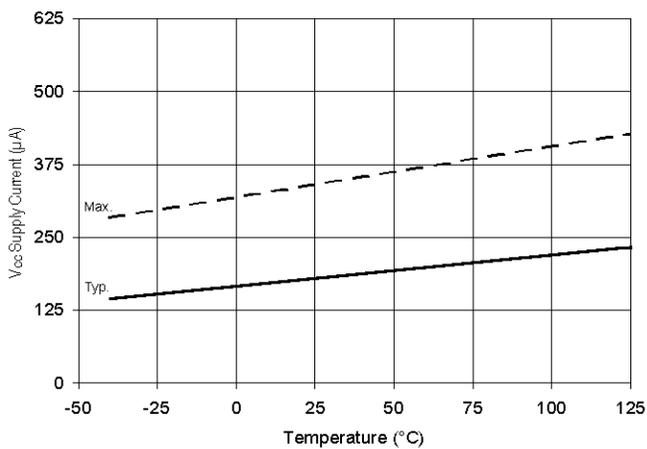


Figure 18A. V_{CC} Supply Current vs. Temperature

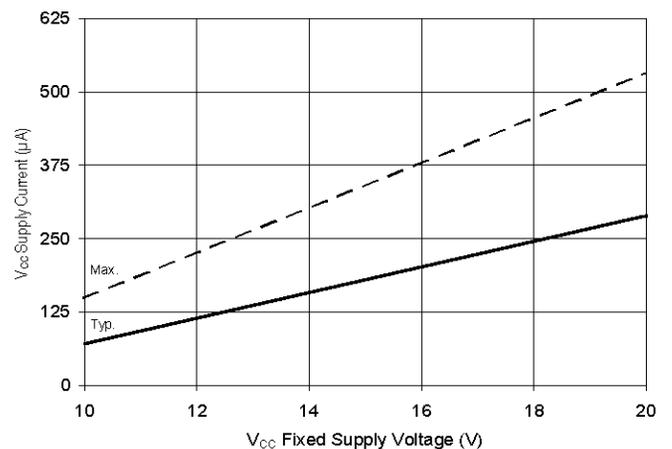


Figure 18B. V_{CC} Supply Current vs. Voltage

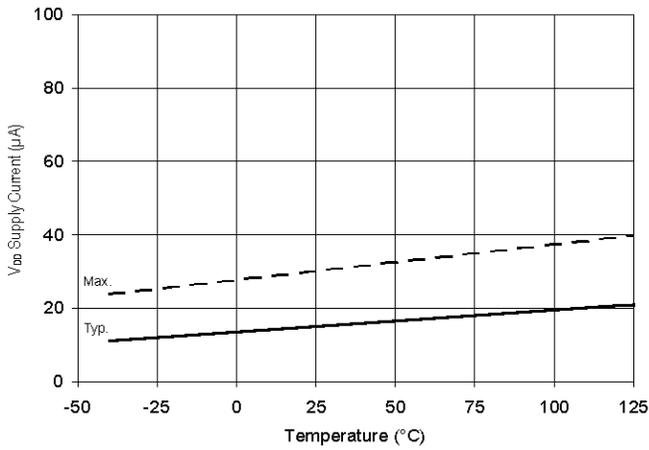


Figure 19A. V_{DD} Supply Current vs. Temperature

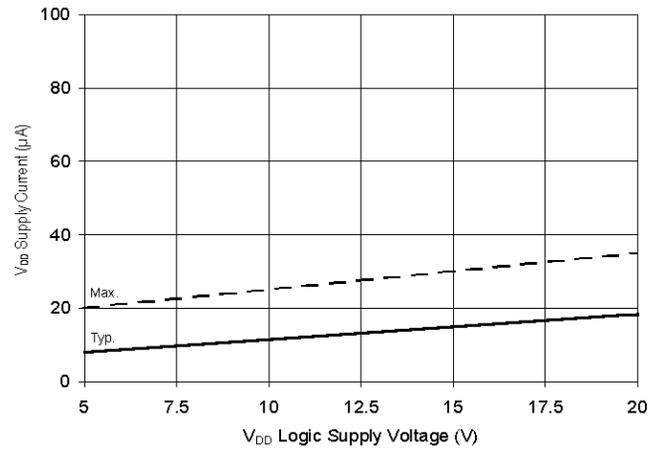


Figure 19B. V_{DD} Supply Current vs. Voltage

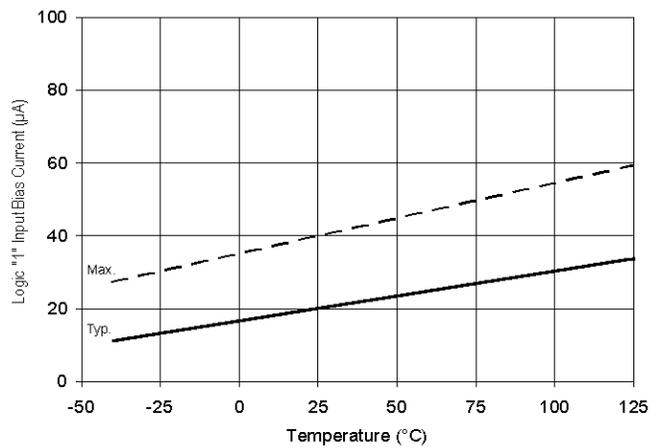


Figure 20A. Logic "1" Input Current vs. Temperature

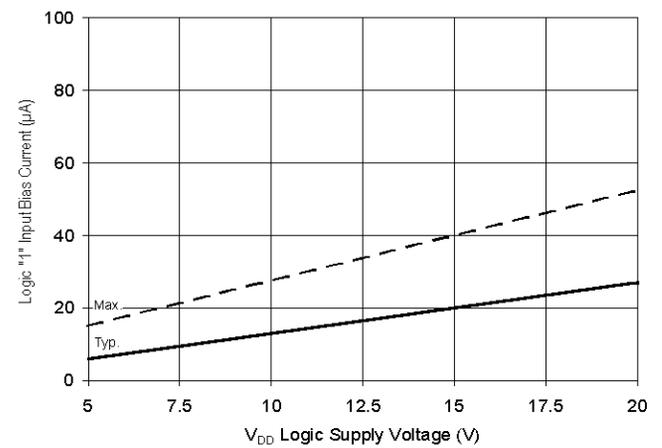


Figure 20B. Logic "1" Input Current vs. Voltage

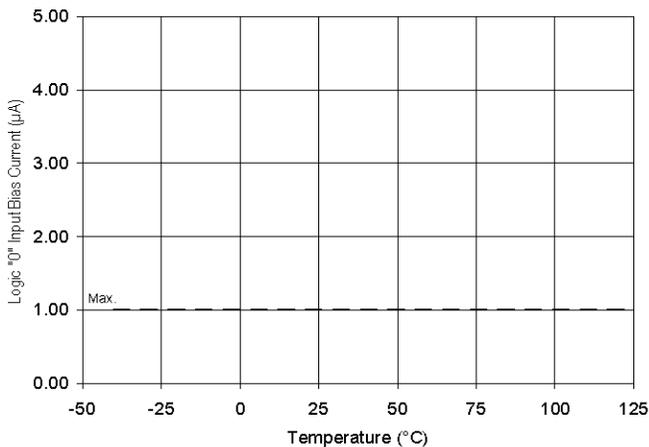


Figure 21A. Logic "0" Input Current vs. Temperature

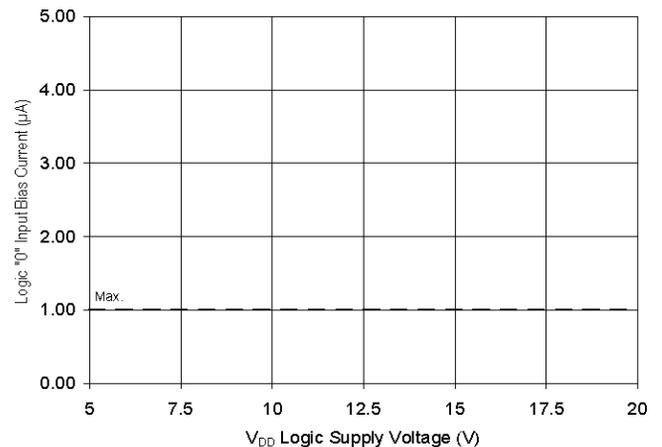


Figure 21B. Logic "0" Input Current vs. Voltage

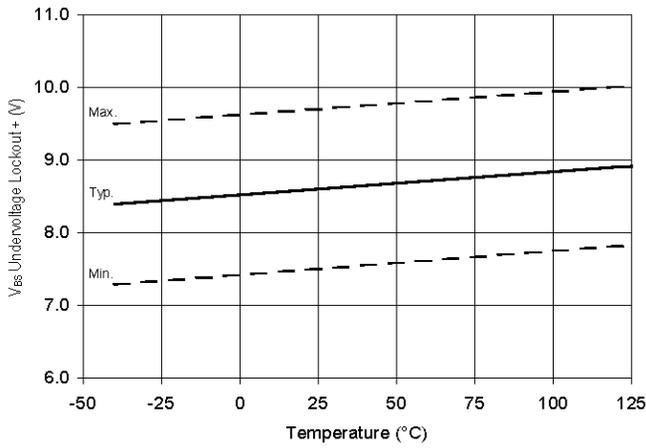


Figure 22. V_{BS} Undervoltage (+) vs. Temperature

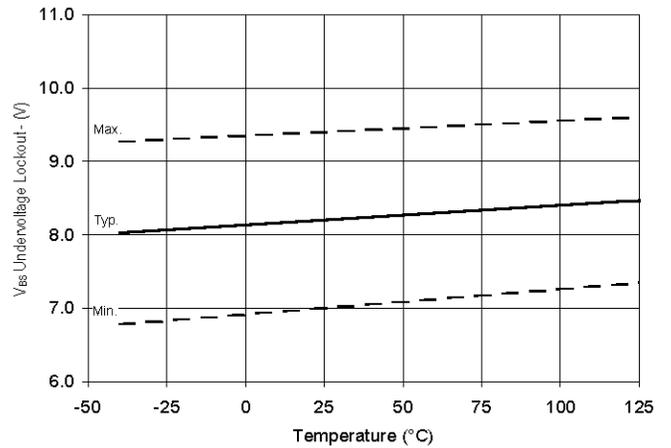


Figure 23. V_{BS} Undervoltage (-) vs. Temperature

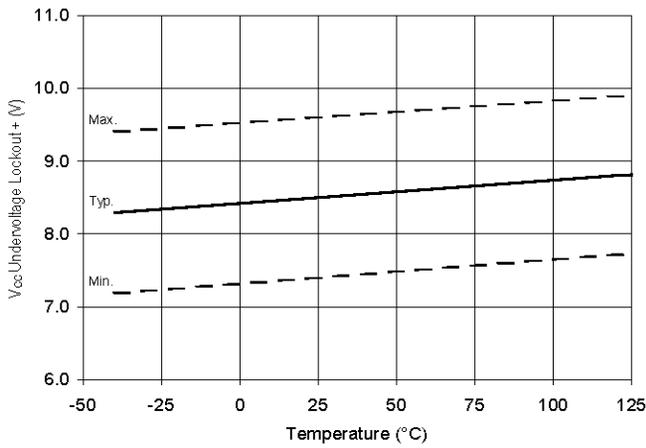


Figure 24. V_{CC} Undervoltage (+) vs. Temperature

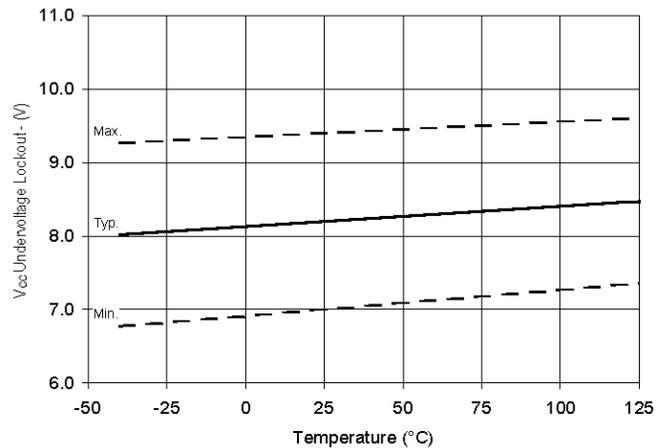


Figure 25. V_{CC} Undervoltage (-) vs. Temperature

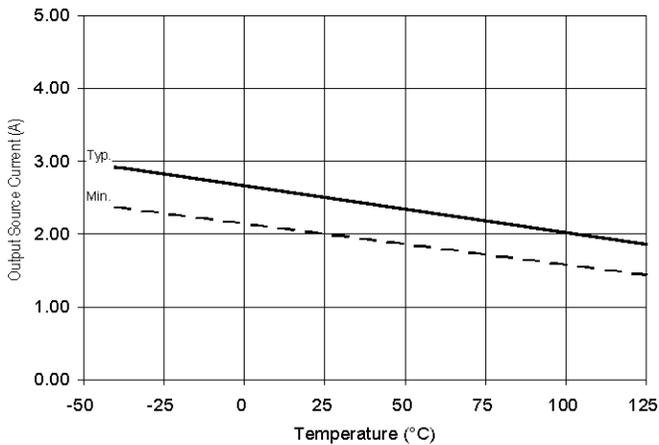


Figure 26A. Output Source Current vs. Temperature

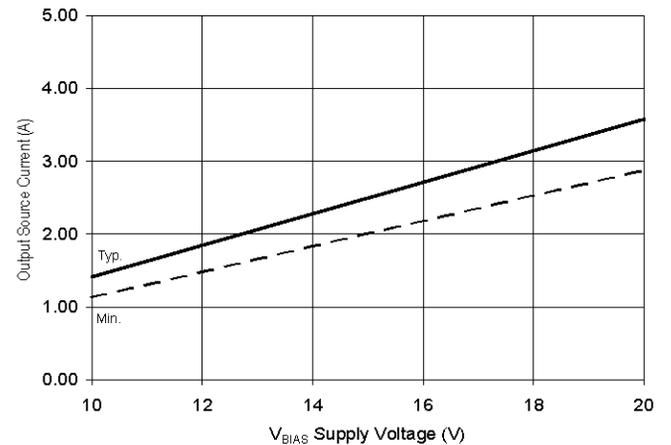


Figure 26B. Output Source Current vs. Voltage

IR2113

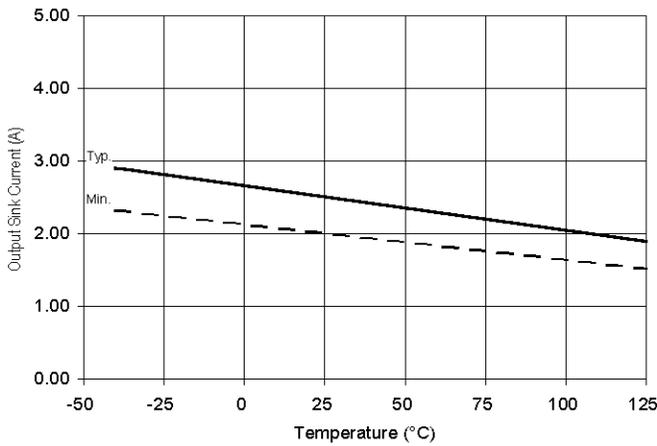


Figure 27A. Output Sink Current vs. Temperature

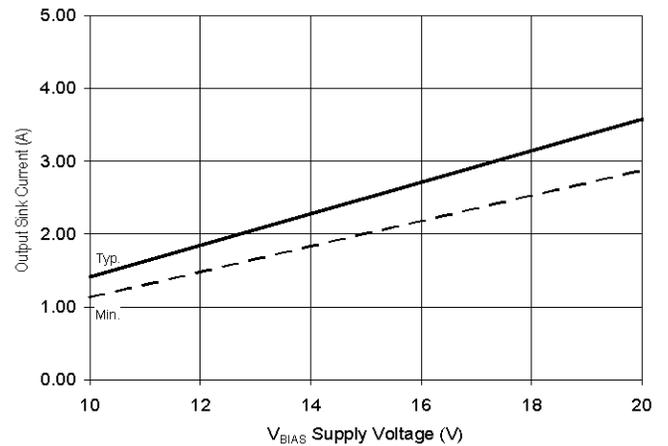
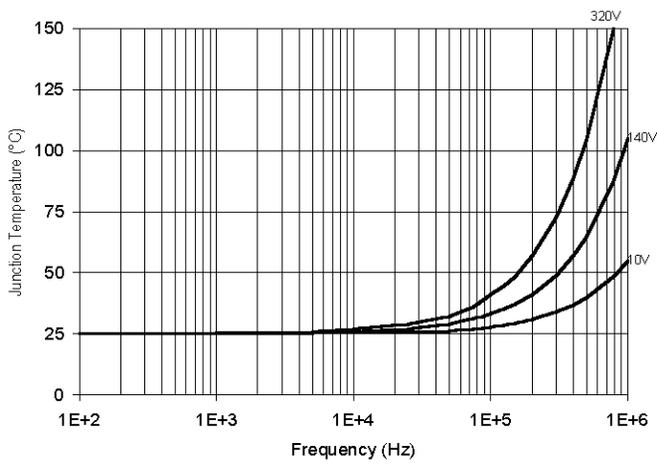
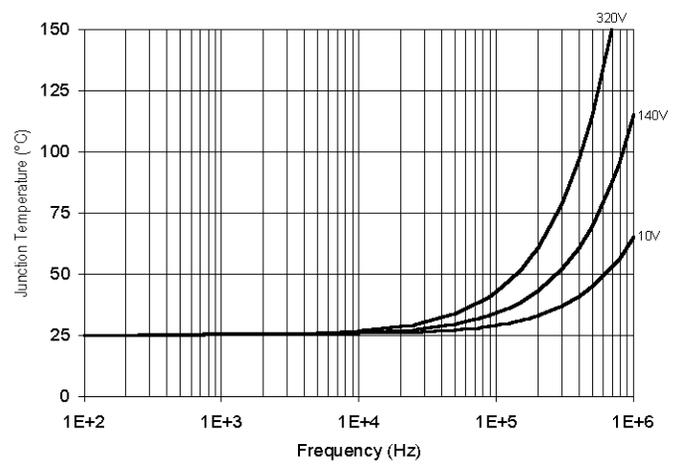


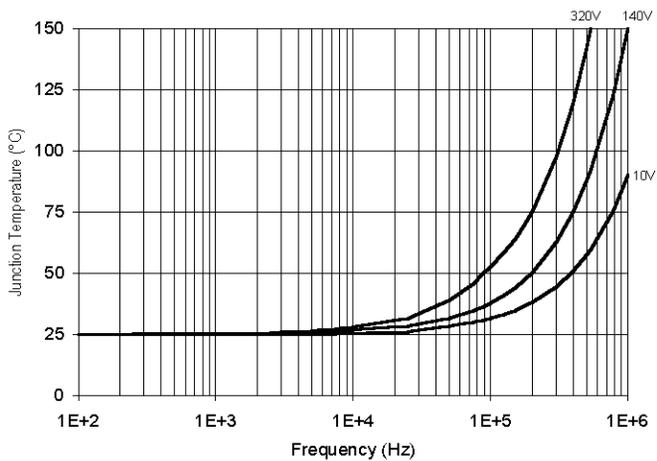
Figure 27B. Output Sink Current vs. Voltage



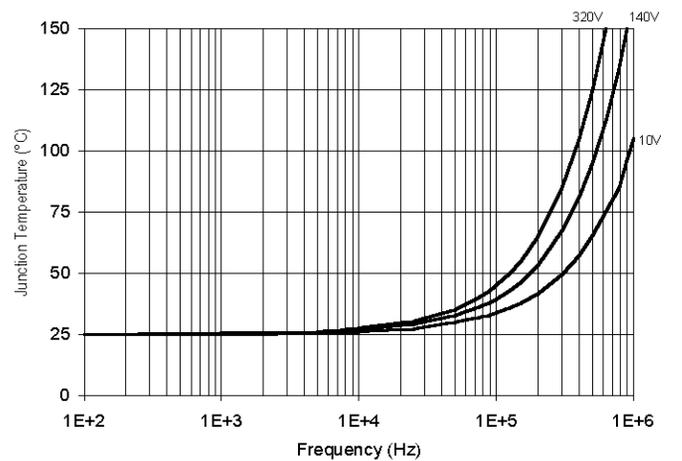
**Figure 28. IR2113 T_J vs. Frequency (IRFBC20)
R_{GATE} = 33Ω, V_{CC} = 15V**



**Figure 29. IR2113 T_J vs. Frequency (IRFBC30)
R_{GATE} = 22Ω, V_{CC} = 15V**



**Figure 30. IR2113 T_J vs. Frequency (IRFBC40)
R_{GATE} = 15Ω, V_{CC} = 15V**



**Figure 31. IR2113 T_J vs. Frequency (IRFPE50)
R_{GATE} = 10Ω, V_{CC} = 15V**



IR2113

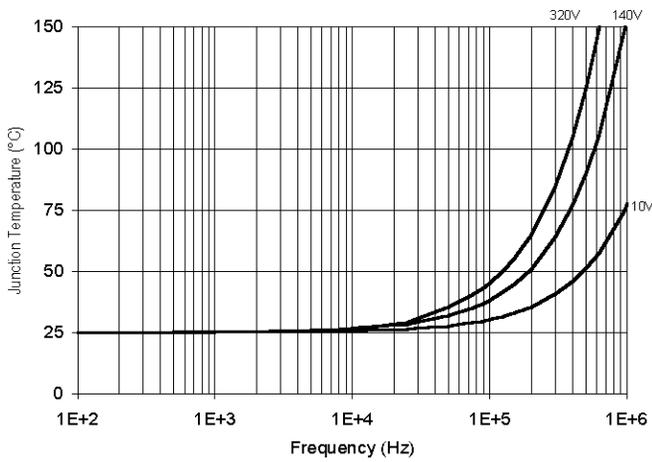


Figure 32. IR2113S T_J vs. Frequency (IRFBC20)
R_{GATE} = 33Ω, V_{CC} = 15V

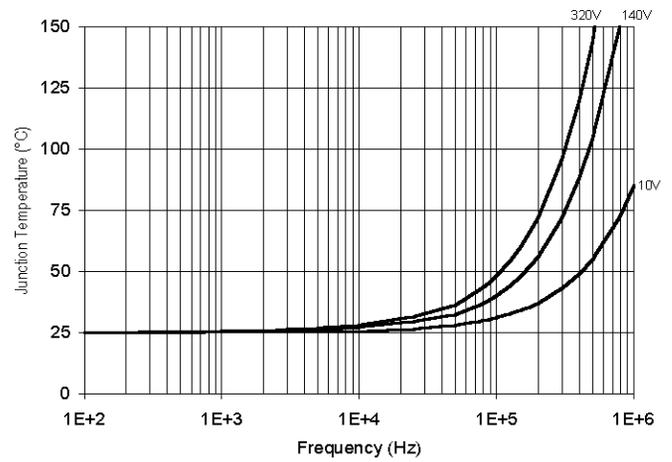


Figure 33. IR2113S T_J vs. Frequency (IRFBC30)
R_{GATE} = 22Ω, V_{CC} = 15V

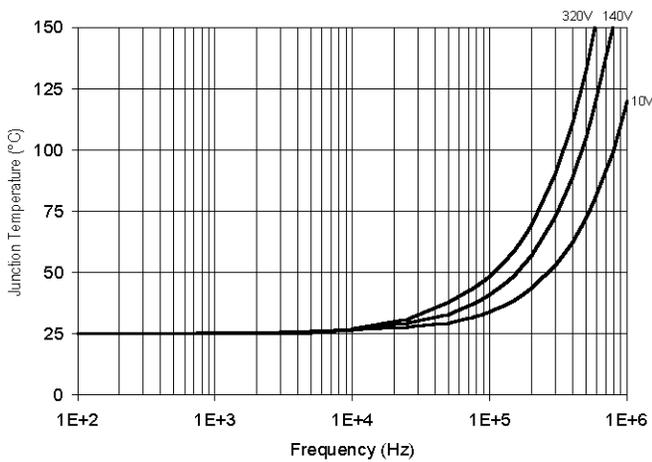


Figure 34. IR2113S T_J vs. Frequency (IRFBC40)
R_{GATE} = 15Ω, V_{CC} = 15V

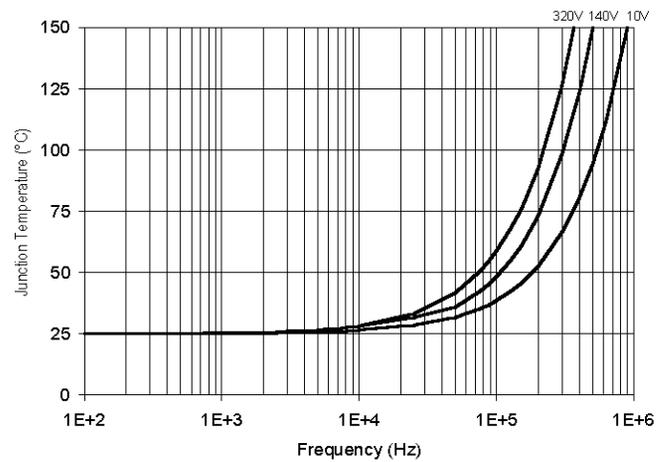


Figure 35. IR2113S T_J vs. Frequency (IRFPE50)
R_{GATE} = 10Ω, V_{CC} = 15V

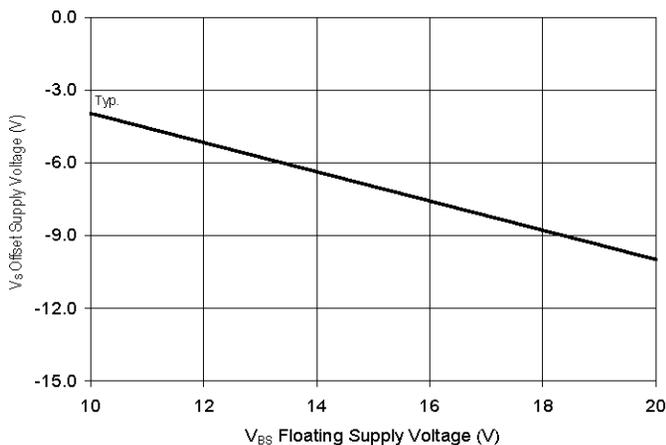


Figure 36. Maximum V_S Negative Offset vs. V_{BS} Supply Voltage

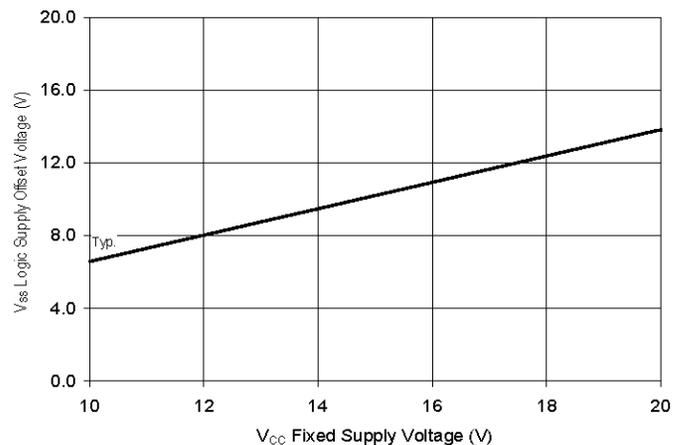


Figure 37. Maximum V_{SS} Positive Offset vs. V_{CC} Supply Voltage